

**MSCSM120AM042CT6AG**  
**Datasheet**  
**Phase Leg SiC Power Module**

January 2020



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# 1 Revision History

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The revision history describes the changes that were implemented in the document. The changes are listed by revision, starting with the most current publication.

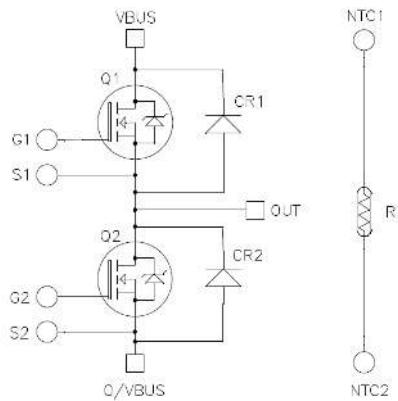
## 1.1 Revision 1.0

Revision 1.0 is the first publication of this document, published in January 2020.

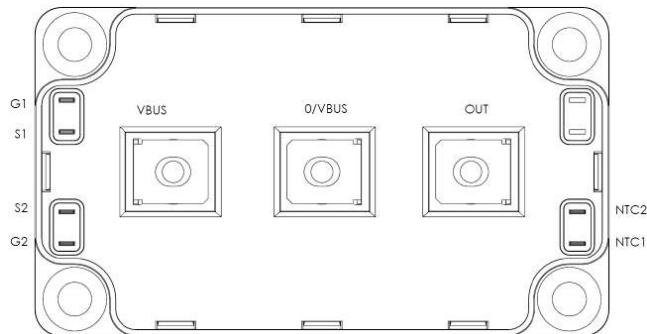
## 2 Product Overview

The MSCSM120AM042CT6AG is a phase leg 1200 V/495 A Silicon Carbide power module.

**Figure 1 • MSCSM120AM042CT6AG Electrical Schematic**



**Figure 2 • MSCSM120AM042CT6AG Pinout Location**



All ratings at  $T_j = 25^\circ\text{C}$  unless otherwise specified.

**Caution:** These devices are sensitive to electrostatic discharge. Proper handling procedures should be followed.

## 2.1 Features

The following are key features of the MSCSM120AM042CT6AG device:

- SiC Power MOSFET
  - Low RDS(on)
  - High temperature performance
- Silicon carbide (SiC) Schottky diode
  - Zero reverse recovery
  - Zero forward recovery
  - Temperature-independent switching behavior
  - Positive temperature coefficient on VF
- Kelvin source for easy drive
- Low stray inductance
- M5 power connectors
- Internal thermistor for temperature monitoring
- Aluminum nitride (AlN) substrate for improved thermal performance

## 2.2 Benefits

The following are benefits of the MSCSM120AM042CT6AG device:

- High efficiency converters
- Outstanding performance at high frequency operation
- Stable temperature behavior
- Direct mounting to heatsink (isolated package)
- Low junction-to-case thermal resistance
- RoHS compliant

## 2.3 Applications

The MSCSM120AM042CT6AG device is designed for the following applications:

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- EV motor and traction drive

## 3 Electrical Specifications

This section shows the electrical specifications of the MSCSM120AM042CT6AG device.

### 3.1 SiC MOSFET Characteristics (Per MOSFET)

This section describes the electrical characteristics of the MSCSM120AM042CT6AG device.

**Table 1 • Absolute Maximum Ratings**

Symbol	Parameter	Maximum Ratings		Unit
$V_{DSS}$	Drain-source voltage	1200		V
$I_D$	Continuous drain current	$T_C = 25\text{ }^\circ\text{C}$	495 <sup>1</sup>	A
		$T_C = 80\text{ }^\circ\text{C}$	395 <sup>1</sup>	
$I_{DM}$	Pulsed drain current	990		
$V_{GS}$	Gate-source voltage	−10/25		V
$R_{DSon}$	Drain-source ON resistance	5.2		$\text{m}\Omega$
$P_D$	Power dissipation	$T_C = 25\text{ }^\circ\text{C}$	2031	W

**Note:**

1. Specification of SiC MOSFET device but output current must be limited due to the size of power connectors.

**Table 2 • Electrical Characteristics**

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
$I_{DSS}$	Zero gate voltage drain current	$V_{GS} = 0\text{ V}$ ; $V_{DS} = 1200\text{ V}$			60	600	$\mu\text{A}$
$R_{DSon}$	Drain–source on resistance	$V_{GS} = 20\text{ V}$	$T_J = 25\text{ }^\circ\text{C}$		4.2	5.2	$\text{m}\Omega$
		$I_D = 240\text{ A}$	$T_J = 175\text{ }^\circ\text{C}$		6.7		
$V_{GS(th)}$	Gate threshold voltage	$V_{GS} = V_{DS}$ , $I_D = 6\text{ mA}$		1.8	2.8		V
$I_{GSS}$	Gate–source leakage current	$V_{GS} = 20\text{ V}$ , $V_{DS} = 0\text{ V}$				600	nA

**Table 3 • Dynamic Characteristics**

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
$C_{iss}$	Input capacitance	$V_{GS} = 0 \text{ V}$ $V_{DS} = 1000 \text{ V}$ $f = 1 \text{ MHz}$		18.1		pF
$C_{oss}$	Output capacitance			1.6		
$C_{rss}$	Reverse transfer capacitance			0.15		
$Q_g$	Total gate charge	$V_{GS} = -5/20 \text{ V}$ $V_{Bus} = 800 \text{ V}$ $I_D = 240 \text{ A}$		1392		nC
$Q_{gs}$	Gate-source charge			246		
$Q_{gd}$	Gate-drain charge			300		
$T_{d(on)}$	Turn-on delay time	$V_{GS} = -5/20 \text{ V}$ $V_{Bus} = 600 \text{ V}$ $I_D = 300 \text{ A}$ $T_J = 150 \text{ }^\circ\text{C}$ $R_{Gon} = 1.3\Omega$ ; $R_{Goff} = 0.8\Omega$		56		ns
$T_r$	Rise time			55		
$T_{d(off)}$	Turn-off delay time			166		
$T_f$	Fall time			67		
$E_{on}$	Turn on energy	$V_{GS} = -5/20 \text{ V}$ $V_{Bus} = 600 \text{ V}$ $I_D = 300 \text{ A}$ $R_{Gon} = 1.3\Omega$ $R_{Goff} = 0.8\Omega$	$T_J = 150 \text{ }^\circ\text{C}$	6.1		mJ
$E_{off}$	Turn off energy		$T_J = 150 \text{ }^\circ\text{C}$	5.5		mJ
$R_{Gint}$	Internal gate resistance			1		$\Omega$
$R_{thJC}$	Junction-to-case thermal resistance				0.07 4	$^\circ\text{C}/\text{W}$

**Table 4 • Body Diode Ratings and Characteristics**

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
$V_{SD}$	Diode forward voltage	$V_{GS} = 0 \text{ V}$ ; $I_{SD} = 240 \text{ A}$		4		V
		$V_{GS} = -5 \text{ V}$ ; $I_{SD} = 240 \text{ A}$		4.2		
$t_{rr}$	Reverse recovery time	$I_{SD} = 240 \text{ A}$ ; $V_{GS} = -5 \text{ V}$ ; $V_R = 800 \text{ V}$ ; $dI/dt = 600 \text{ A}/\mu\text{s}$		90		ns
$Q_{rr}$	Reverse recovery charge			3300		
$I_{rr}$	Reverse recovery current			81		

## 3.2 SiC Schottky Diode Ratings Characteristics (Per SiC Diode)

This section shows the SiC Schottky diode ratings and characteristics of the device.

**Table 5 • SiC Schottky Diode Ratings and Characteristics**

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
$V_{RRM}$	Peak repetitive reverse voltage					1200	V
$I_{RRM}$	Reverse leakage current	$V_R = 1200 \text{ V}$	$T_J = 25^\circ\text{C}$	60	1200	$\mu\text{A}$	
					900		
$I_F$	Forward current		$T_C = 100^\circ\text{C}$		180		A
$V_F$	Diode forward voltage	$I_F = 180 \text{ A}$	$T_J = 25^\circ\text{C}$		1.5	1.8	V
			$T_J = 175^\circ\text{C}$		2.1		
$Q_C$	Total capacitive charge	$V_R = 600 \text{ V}$			780		nC
$C$	Total capacitance	$f = 1 \text{ MHz}, V_R = 400 \text{ V}$			846		pF
			$f = 1 \text{ MHz}, V_R = 800 \text{ V}$		630		
$R_{thJC}$	Junction-to-case thermal resistance					0.175	$^\circ\text{C}/\text{W}$

## 3.3 Thermal and Package Characteristics

This section shows the thermal and package characteristics of the device.

**Table 6 • Package Characteristics**

Symbol	Characteristic	Min	Max	Unit		
$V_{ISOL}$	RMS isolation voltage, any terminal to case $t = 1 \text{ min}, 50/60 \text{ Hz}$	4000		V		
$T_J$	Operating junction temperature range	-40	175	$^\circ\text{C}$		
$T_{JOP}$	Recommended junction temperature under switching conditions	-40	$T_{Jmax} - 25$	$^\circ\text{C}$		
$T_{STG}$	Storage temperature range	-40	125	$^\circ\text{C}$		
$T_C$	Operating case temperature	-40	125	$^\circ\text{C}$		
Torque	Mounting torque	For terminals	M6	3	5	N.m
		To heatsink	M5	2	3.5	
Wt	Package weight			300	g	

**Table 7 • Temperature Sensor NTC<sup>1</sup>**

Symbol	Characteristic	Min	Typ	Max	Unit
R <sub>25</sub>	Resistance at 25 °C		50		kΩ
ΔR <sub>25</sub> /R <sub>25</sub>			5		%
B <sub>25/85</sub>	T <sub>25</sub> = 298.15 K		3952		K
ΔB/B		T <sub>C</sub> = 100 °C	4		%

$$R_T = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]} \quad \begin{array}{l} T: \text{Thermistor temperature} \\ R_T: \text{Thermistor value at } T \end{array}$$

**Note:**

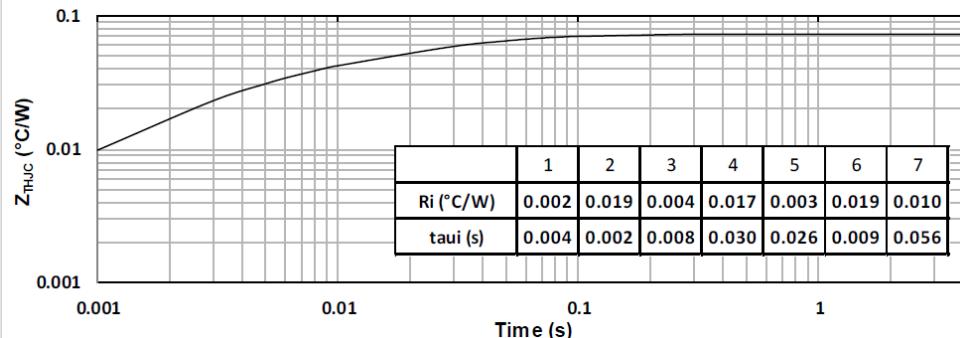
1. See the application note APT0406 on [www.microsemi.com](http://www.microsemi.com).

### 3.4

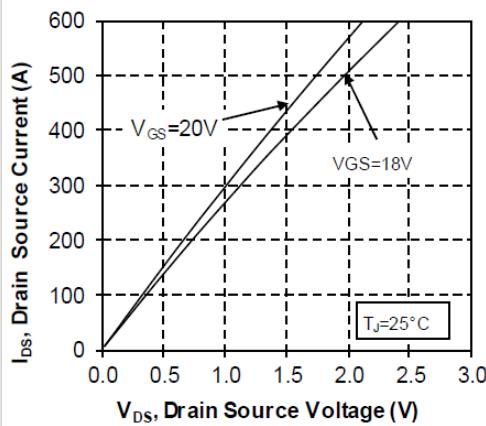
### Typical SiC MOSFET Performance Curves

This section shows the typical performance curves of the MSCSM120AM042CT6AG SiC MOSFET.

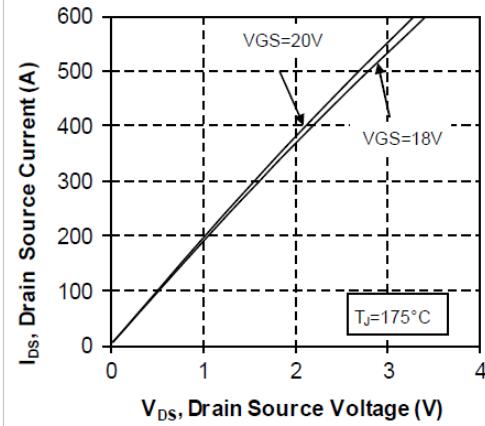
**Figure 3 • Maximum Thermal Impedance**



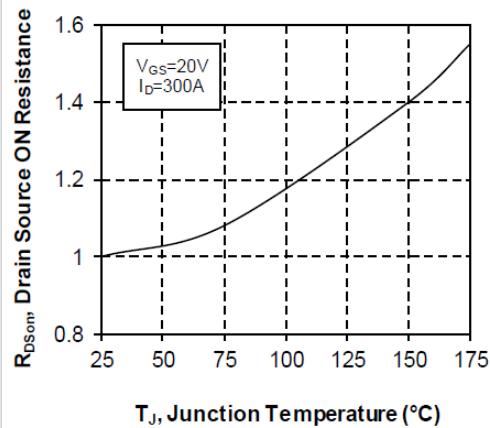
**Figure 4 • Output Characteristics at  $T_J = 25^{\circ}\text{C}$**



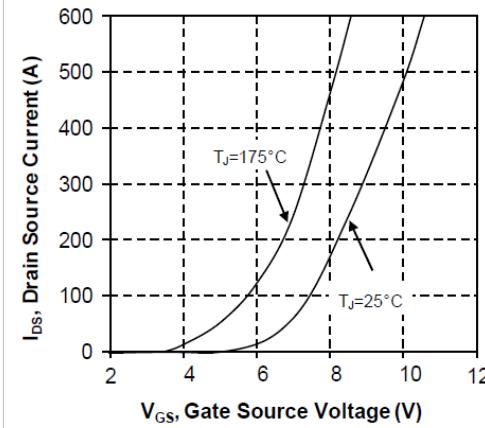
**Figure 5 • Output Characteristics at  $T_J = 175^{\circ}\text{C}$**

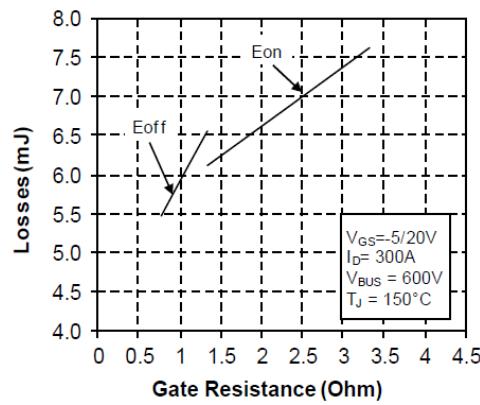
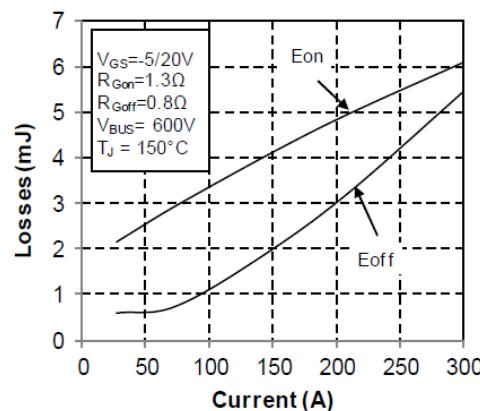
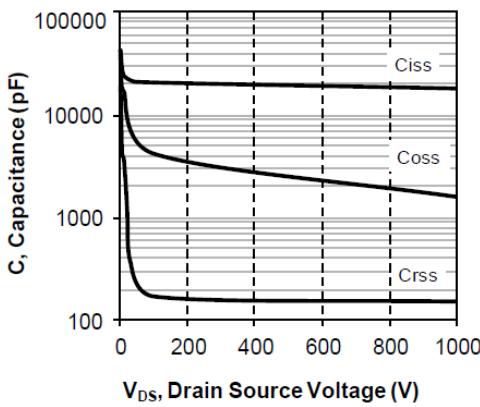
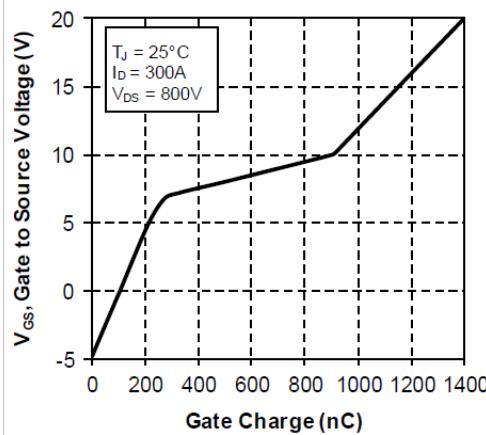
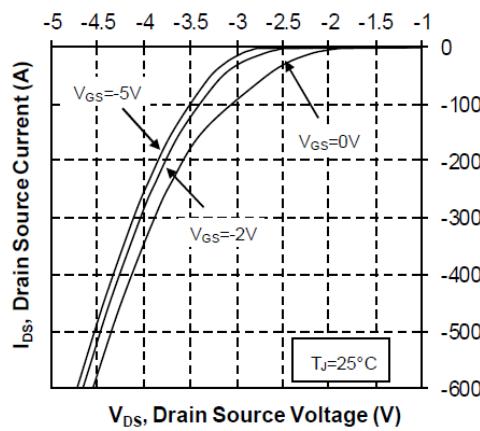
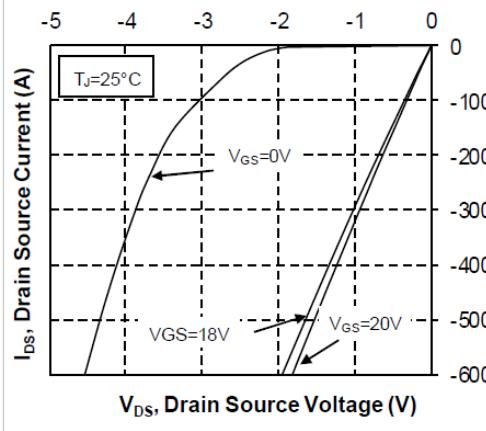


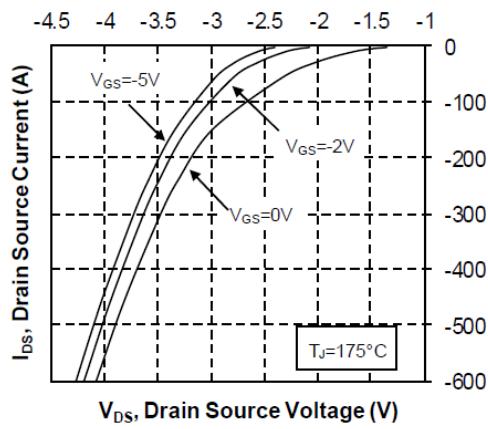
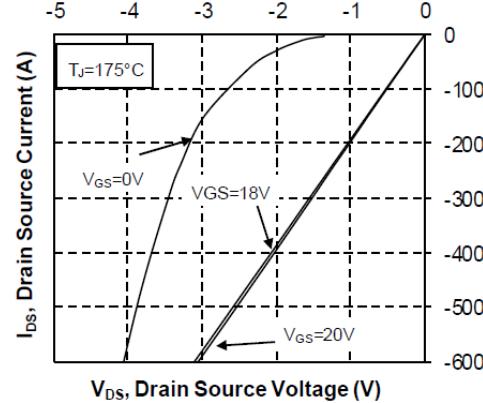
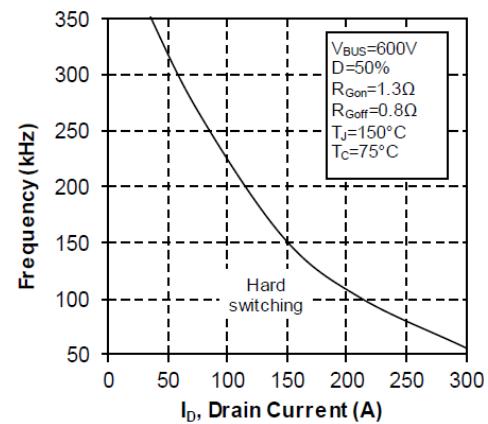
**Figure 6 • Normalized RDS(on) vs. Temperature**



**Figure 7 • Transfer Characteristics**



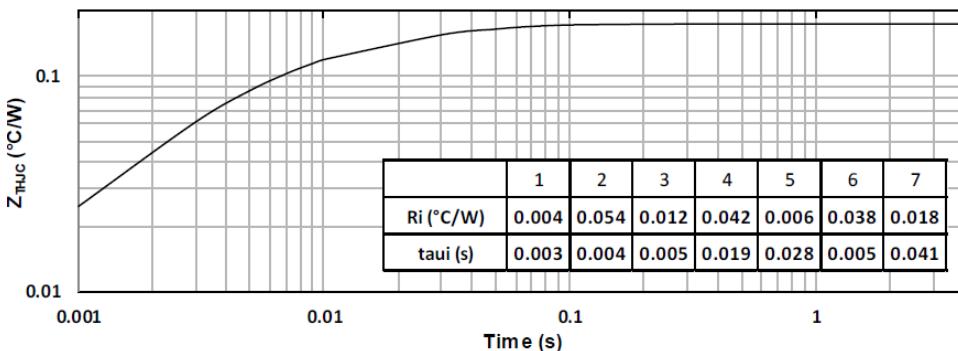
**Figure 8 • Switching Energy vs. R<sub>g</sub>****Figure 9 • Switching Energy vs. Current****Figure 10 • Capacitance vs. Drain Source Voltage****Figure 11 • Gate Charge vs. Gate Source Voltage****Figure 12 • Body Diode Characteristics,  $T_J = 25^\circ C$** **Figure 13 • 3<sup>rd</sup> Quadrant Characteristics,  $T_J = 25^\circ C$** 

**Figure 14 • Body Diode Characteristics,  $T_J = 175^\circ\text{C}$** **Figure 15 • 3<sup>rd</sup> Quadrant Characteristics,  $T_J = 175^\circ\text{C}$** **Figure 16 • Operating Frequency vs. Drain Current**

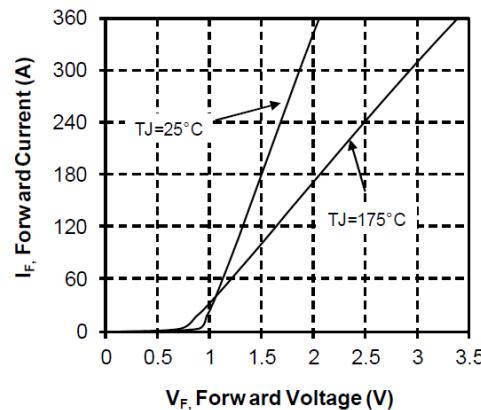
### 3.5 Typical SiC Diode Performance Curves

This section shows the typical performance curves of the MSCSM120AM042CT6AG SiC diode.

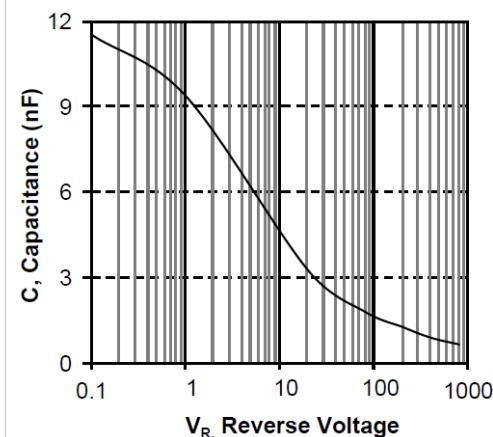
**Figure 17 • Maximum Thermal Impedance**



**Figure 18 • Forward Characteristics**



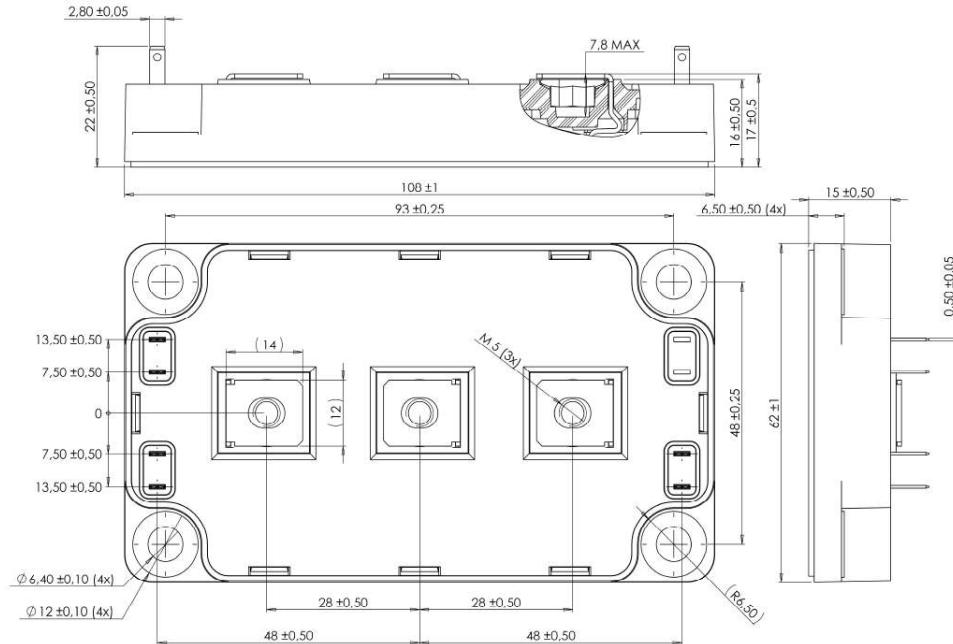
**Figure 19 • Capacitance vs. Reverse Voltage**



## 4 Package Specification

This section shows the package outline of the MSCSM120AM042CT6AG device. All dimensions are in millimeters.

**Figure 20 • Package Outline**



See application note APT0601 - Mounting Instructions for SP6 Power Modules on [www.microsemi.com](http://www.microsemi.com).



**Microsemi**  
2355 W. Chandler Blvd.  
Chandler, AZ 85224 USA

Within the USA: +1 (480) 792-7200  
Fax: +1 (480) 792-7277

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